Architecture Aptitude Test (AAT) 2023

IMPORTANT INSTRUCTIONS FOR CANDIDATES

- Report at the examination centre at 08:00 hours IST on June 21, 2023 for appearing in AAT 2023 examination.

- Examination will commence at 09:00 hours IST on June 21, 2023. You will NOT be allowed to enter the examination centre after the commencement of the examination. You will NOT be allowed to leave the examination hall before the end of the examination.

- A printout of JEE (Advanced) 2023 Admit Card must be presented for verification at the examination centre/hall.

- Documents that MUST be brought to the examination centre: Printout of the Admit Card and at least one ORIGINAL photo identity card (Aadhaar, School ID, Driving License, Voter ID, Passport, PAN Card).

- After your entry to the examination centre, identity verification will be done before the commencement of AAT 2023 examination. After completing this process, you will be required to take your assigned seat in the examination hall by 08:30 hours IST.

- The AAT 2023 examination will consist of one paper of three hours duration. The question paper for AAT will be available only in the English language.

- You should bring your own pen/pencil, drawing and colouring aids. Those items will NOT be given at the examination centre. You are strongly advised to carry your own drinking water in a transparent bottle.

- You should not be in possession of any of the prohibited items listed below: Smart/digital/programmable watches, analog watches, timepieces, mobile phones, Bluetooth devices, ear-phones, microphones, pagers, health bands or any other electronic gadgets, any printed/blank/hand written paper, log tables, writing pads, scales, geometry/pencil-boxes, pouches, calculators, pen drives, electronic pens, wallets, handbags, goggles or similar items are NOT allowed inside the examination centre.

If you are found to possess any of the prohibited items, you will be debarred from the examination and/or subjected to disciplinary action, which may include ban from appearing in future examinations.